

# UNISONIC TECHNOLOGIES CO., LTD

UF3N10 Power MOSFET

# 3A, 100V N-CHANNEL ENHANCEMENT MODE POWER MOSFET

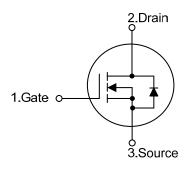
## **■** DESCRIPTION

The UTC **UF3N10** is a N-channel power MOSFET providing very low on-resistance. It has high efficiency and perfect cost-effectiveness. It can be generally applied in the commercial and industrial fields.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.33  $\Omega$  @  $V_{GS}$  =10V,  $I_{D}$  =1.5A
- \* Simple drive requirement

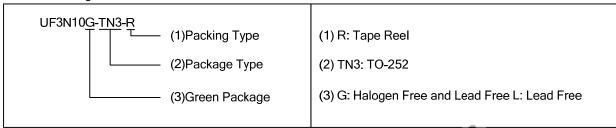
## ■ SYMBOL



## ORDERING INFORMATION

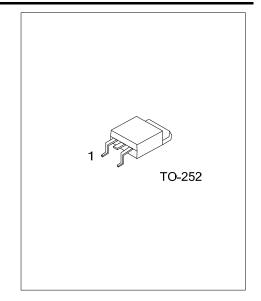
Ordering Number		Dooksays	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UF3N10L-TN3-R	UF3N10G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



# ■ MARKING





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**UF3N10 Power MOSFET** 

# **ABSOLUTE MAXIMUM RATING** (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	100	V	
Gate-Source Voltage		$V_{GSS}$	±20	V	
Drain Current	Continuous	$I_{D}$	3	Α	
	Pulsed (Note 2)	$I_{DM}$	9	Α	
Avalanche Energy (Note 3)	Single Pulsed (Note 3)	E <sub>AS</sub>	77	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	20	V/ns	
Power Dissipation		$P_D$	25	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 17 mH,  $I_{AS}$  = 3.0 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C.
- 4.  $I_{SD} \le 3.0$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J = 25$ °C.

#### THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	1211	θ <sub>ЈА</sub>	110	°C/W	
Junction to Case		θυς	5	°C/W	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> =25°C, unless otherwise specified)

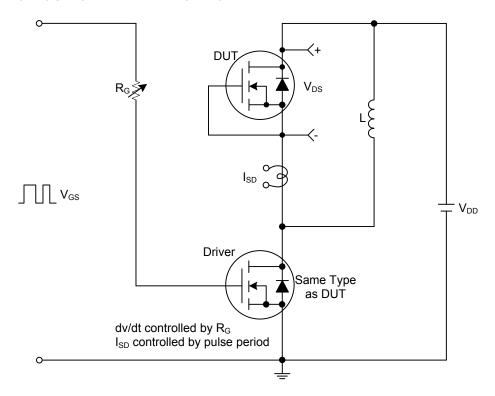
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	$V_{GS} = 0V, I_D = 250 \mu A$	100			V			
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =100V,V <sub>GS</sub> =0V			10	μΑ			
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V			±100	nA			
ON CHARACTERISTICS									
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	2.0		4.0	V			
Drain to Source On-state Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =1.5A			0.33	Ω			
DYNAMIC PARAMETERS									
Input Capacitance	C <sub>ISS</sub>			255		pF			
Output Capacitance	Coss	$V_{DS}$ =25V, $V_{GS}$ =0V,f =1.0MHz		43		pF			
Reverse Transfer Capacitance	C <sub>RSS</sub>			7		pF			
SWITCHING PARAMETERS									
Total Gate Charge (Note 1)	$Q_G$	\\ -90\\ \\ -10\\   -2.0\		11.2		nC			
Gate Source Charge	$Q_GS$	$V_{DS}$ =80V, $V_{GS}$ =10V, $I_{D}$ =3.0A, $I_{G}$ =1mA (Note 1, 2)		5.7		nC			
Gate Drain Charge	$Q_GD$			1.8		nC			
Turn-ON Delay Time (Note 1)	t <sub>D(ON)</sub>			2.2		ns			
Turn-ON Rise Time	t <sub>R</sub>	$V_{DD}$ =50V, $V_{GS}$ =10V, $I_{D}$ =3.0A,		15.5		ns			
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	$R_G = 25\Omega$ (Note 1, 2)		3.8		ns			
Turn-OFF Fall-Time	t <sub>F</sub>			2.6		ns			
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Maximum Body-Diode Continuous Current	Is				3	Α			
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>	~ **	-0		9	Α			
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =3.0A, V <sub>GS</sub> =0V	(1,		1.2	V			
Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =3.0A,V <sub>GS</sub> =0V,		50		ns			
Reverse Recovery Charge	Q <sub>rr</sub>	dl/dt=100A/µs		106		nC			

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

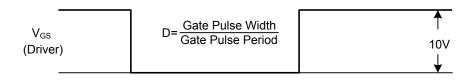
2. Essentially independent of operating ambient temperature.

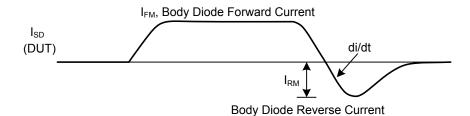
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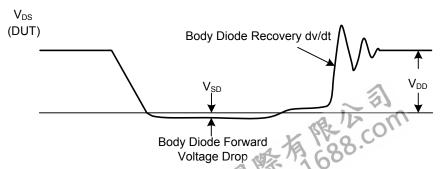
# **■ TEST CIRCUITS AND WAVEFORMS**



# Peak Diode Recovery dv/dt Test Circuit





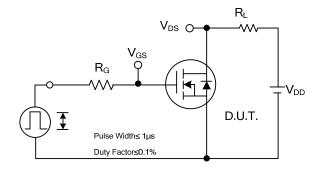


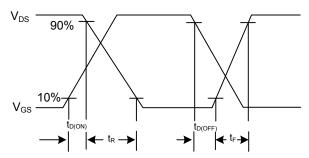
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

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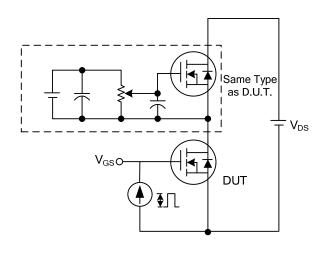
# **TEST CIRCUITS AND WAVEFORMS**

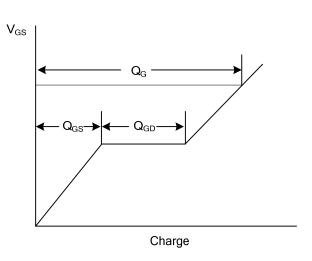




**Switching Test Circuit** 

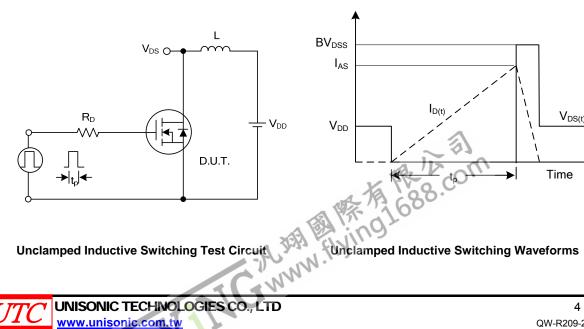
**Switching Waveforms** 

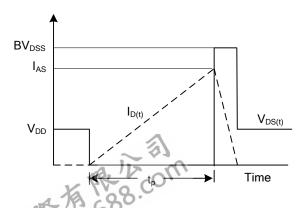




**Gate Charge Test Circuit** 

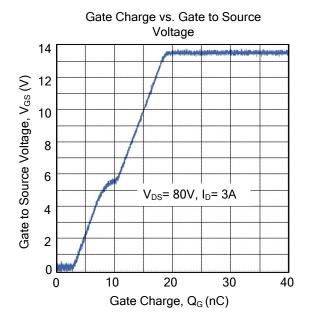
**Gate Charge Waveform** 

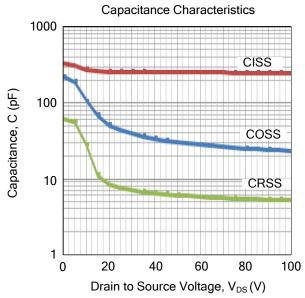




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#### ■ TYPICAL CHARACTERISTICS





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